

Notice of References Cited	Application/Control No. 10/615,404		Applicant(s)/Patent Under Reexamination ONOE ET AL.	
	Examiner TAN X. DINH		Art Unit 2653	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,646,932	07-1997	Kuribayashi et al.	369/275.3
*	B	US-5,914,920 A	06-1999	Yokogawa, Fumihiko	369/275.3
*	C	US-6,510,130 B2	01-2003	Hayashi et al.	369/275.3
*	D	US-6,965,545 B2	11-2005	Hino et al.	369/13.54
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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